



GP/2877

PATENT
81208-246275

#9
13 SEP 00
R. Tallor

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:
NIELSEN, Henrik K., et al.
Serial No.: 09/195,533
Filed: November 18, 2000
For: DETECTION SYSTEM FOR
NANOMETER SCALE TOPOGRAPHIC
MEASUREMENTS OF REFLECTIVE
SURFACES

Group No.: 2877

Examiner: R. Rosenberger

RECEIVED
SEP -8 2:30
TC 2800 MAIL ROOM

TRANSMITTAL OF INFORMATION DISCLOSURE STATEMENT

Asst. Commissioner for Patents
Washington, D.C. 20231

Dear Sirs:

I, the person signing below, certify that each item of information contained in the information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application and that the communication is dated not more than three months prior to the filing of the statement. 37 C.F.R. §1.97(e)(1).

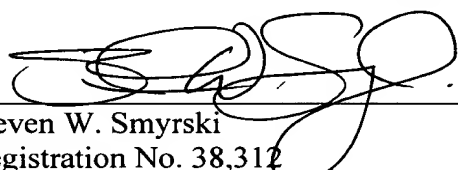
If it should be determined that for any reason either an insufficient or an excessive fee has been paid, please charge any insufficiency or credit any overpayment necessary to ensure consideration of the information disclosure statement for the above-identified application to Deposit Account No. 16-1805. A copy of this petition is enclosed.

Respectfully submitted,

PILLSBURY MADISON & SUTRO LLP

Dated: August 28, 2000

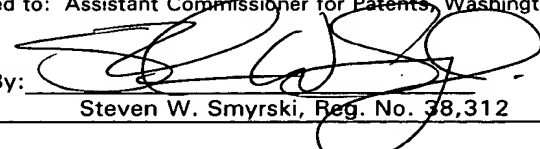
By:


Steven W. Smyrski
Registration No. 38,312
Attorney for Applicant(s)

725 South Figueroa Street, Suite 1200
Los Angeles, CA 90017-5443
Telephone: (213) 488-7100
Facsimile: (213) 629-1033

I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as first class mail in an envelope addressed to: Assistant Commissioner for Patents, Washington D.C. 20231, on August 28, 2000.

By:


Steven W. Smyrski, Reg. No. 38,312